Silicon N-channel IGBT 1700V F version

FEATURES

- * Soft switching behavior & low conduction loss:
 - Soft low-injection punch-through with
 - Advanced trench HiGT* (*High conductivity IGBT).
- * Low driving power:
 - Low input capacitance advanced trench gate.
- * Low noise recovery: Ultra soft fast recovery diode.

ABSOLUTE MAXIMUM RATINGS (Tc=25°C)

Item		Symbol	Unit	MBL1600E17F		
Collector Emitter Voltage		Vces	V	1.700		
Gate Emitter Voltage	<u> </u>	V _{GES}	V	±20		
Collector Current	DC	Ic	۸	1,600		
Collector Current	1ms	I _{Cp}	A	3,200		
Forward Current	Current DC I _{F(FWD)}		۸	1,200		
(Free wheel Diode)	1ms	I _{FM(FWD)}	Α	2,400		
Forward Current	DC	I _{F(chopper)}	۸	1,200		
(Chopper Diode)	1ms	I _{FM(chopper)}	A	2,400		
Junction Temperatu	ıre	T _{j op}	°C	-50 ~ + 150		
Maximum Junction Temperature(3)		T _{vj max}	°C	175		
Storage Temperature		T _{stg}	°C	-50 ~ +125		
Isolation Voltage		Viso	V _{RMS}	4,000(AC 1 minute)		
Corow Torque	Terminals (M4/M8)	-	NI m	2/15 (1)		
Screw Torque	Mounting (M6)	-	N∙m	6 (2)		

Notes: (1) Recommended Value 1.8±0.2/15⁺⁰-3N·m

(2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS 1) IGBT + FWD

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Oallantan Fraittan Oat Off Oannant	_		-	-	5	V _{CE} =1,700V, V _{GE} =0V, Tj=25°C	
Collector Emitter Cut-Off Current	I CES	mA	-	20 80		V _{CE} =1,700V, V _{GE} =0V, Tj=150°C	
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, Tj=25°C	
Collector Emitter Saturation Voltage	V _{CE(sat)}	V	-	2.0	-	Ic=1,600A, V _{GE} =15V, Tj=25°C	
			2.0	2.4	2.8	Ic=1,600A, V _{GE} =15V, Tj=150°C	
Gate Emitter Threshold Voltage	$V_{GE(TO)}$	V	4.1	5.5	7.1	V _{CE} =10V, I _C =160mA, Tj=25°C	
Input Capacitance	Cies	nF	-	87	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, Tj=25°C	
Internal Gate Resistance	Rge	Ω	-	2.3	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, Tj=25°C	
Turn On Delay Time	t _{d(on)}		-	0.6	1.2	Vcc=900V, Ic=1,600A	
Rise Time	t _r	μS	-	0.4	0.8	Ls=120nH (4)	
Turn Off Delay Time			-	1.8	3.6	$R_G(\text{on/off})=3.9/3.9\Omega$ (4)	
Fall Time	t _f		-	1.4	2.8	V _{GE} =±15V, Tj=150°C	
	V _{FM}	V	-	2.0	-	IF=1,200A, V _{GE} =0V, Tj=25°C	
Forward Voltage Drop						Measured at auxiliary terminals	
Torward Voltage Drop			_	2.3	_	IF=1,200A, V _{GE} =0V, Tj=150°C	
						Measured at auxiliary terminals	
Turn On Loss	Eon	J/P	-	0.5	-	Vcc=900V, Ic=1,600A	
						Ls=120nH (4)	
Turn Off Loss	E _{off}	J/P	-	1.4	-	$R_G(\text{on/off})=3.9/3.9\Omega$ (4) $V_{GE}=\pm15V$, $T_J=150^{\circ}C$	
Stray inductance in module	LSCE	nH	_	12	_	VGE=±13V, 1J=130°C	
ICRT	Rth(j-c)	11111			0.015		
Thermal Impedance FWD	Rth(j-c)	K/W		- 0.015 - 0.033		Junction to case	
IIVU	TXIII(J-C)			_	0.000	Case to fin () grosso-1\M//m.K)	
Contact Thermal Impedance	Rth(c-f)	K/W	-	0.008	-	Case to fin (λgrease=1W/(m·K),	
						heat-sink flatness ≤50um)	

⁽³⁾ Regarding the definition of T_{vj max} for each operation mode, please refer to LD-ES-130737.

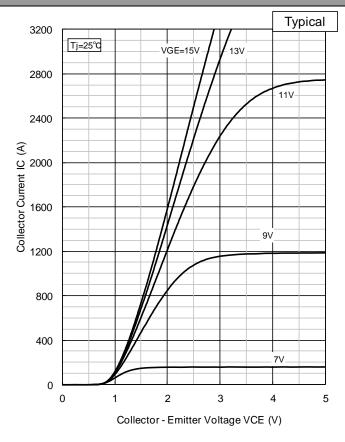
2) Chopper DIODE

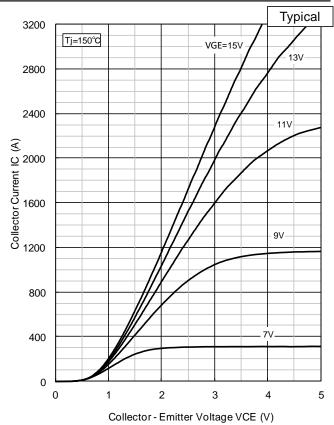
Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Panatitiva Pavaraa Current	IRRM	mA	-	-	2.5	VR=1,700V, Tj=25°C	
Repetitive Reverse Current	IKKW	IIIA	-	10	40	VR=1,700V, Tj=150°C	
	VF V - 2.1 -		IF=1,200A, Tj=25°C				
Forward Voltage Drop		V	-	2.1		Measured at main terminals	
(Between main terminals)			-	2.4	1	IF=1,200A, Tj=150°C	
						Measured at main terminals	
Reverse Recovery Time	trr	μS	-	0.6	-	V _{CC} =900V, IF=1,200A,	
Doverse Descriptulase	Г	J/P		0.5	-	Ls=120nH, $R_G(on)$ =3.9 Ω (4)	
Reverse Recovery Loss	Err	J/P	•	0.5		V _{GE} =±15V, Tj=150°C	
Thermal Impedance	Rth(j-c)	K/W	-	-	0.033	Junction to case	
Contact Thermal Impedance	Rth(c-f)	K/W	-	0.016	-	Case to fin (at Chopper Diode part)	

Notes:(4) Ls and R_G are the test condition's values for evaluation of the switching times, not recommended value. Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

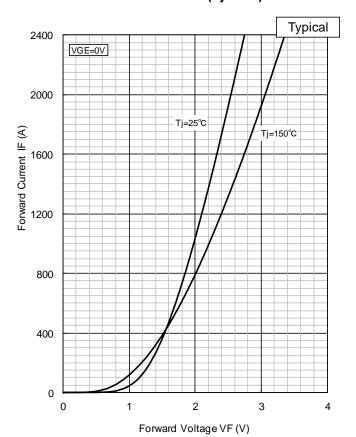
- * Please contact our representatives at order.
- * For improvement, specifications are subject to change without notice.
- * For actual application, please confirm this spec sheet is the newest revision.

 * ELECTRICAL CHARACTERISTIC items shown in above table are according to IEC 60747–2 and IEC 60747–9.





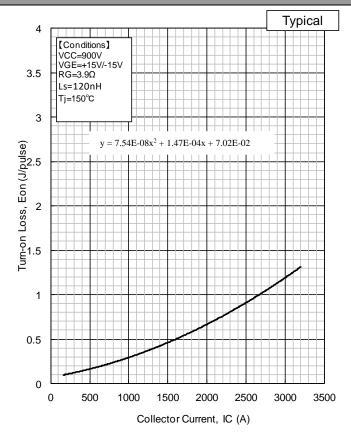
IC vs. VCE (Tj=25℃)



IF vs. VF of Chopper Diode

IC vs. VCE (Tj=150°C)

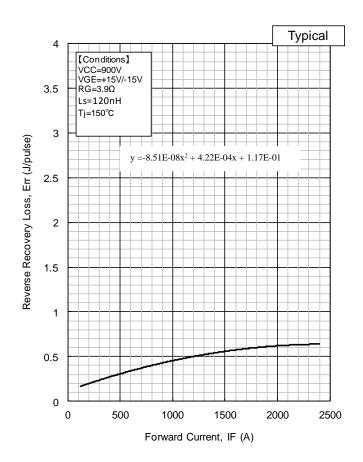
P4

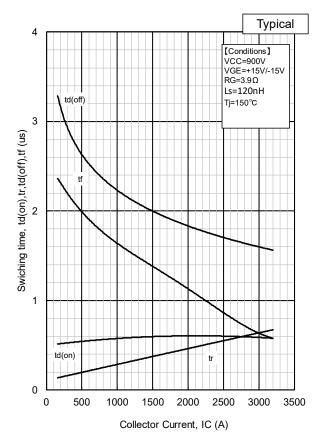


Typical [Conditions] VCC=900V VGE=+15V/-15V 3.5 RG=3.9Ω Ls=120nH Tj=150°C 3 Turn-off Loss, Eoff (J/pulse)
2 5 2 1 0.5 $y = 9.22E-08x^2 + 5.92E-04x + 2.26E-01$ 0 0 500 1000 1500 2500 3000 3500 2000 Collector Current, IC (A)

Turn-on loss vs. Collector current

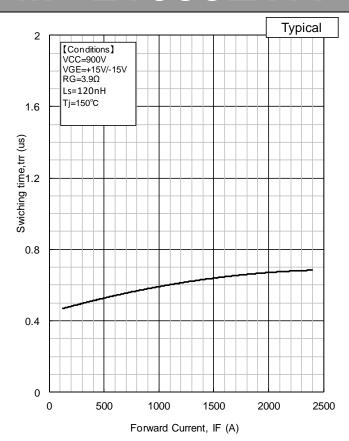




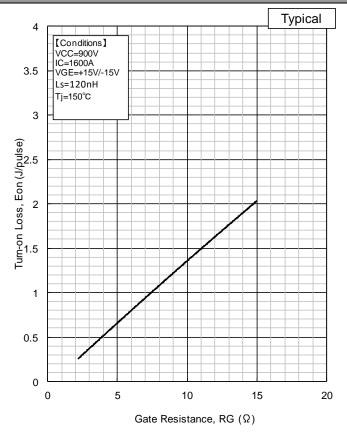


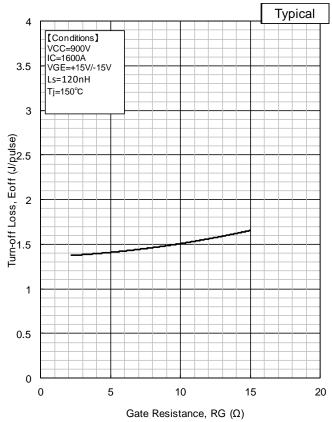
Recovery loss vs. Forward current of chopper diode

Switching time vs. Collector current



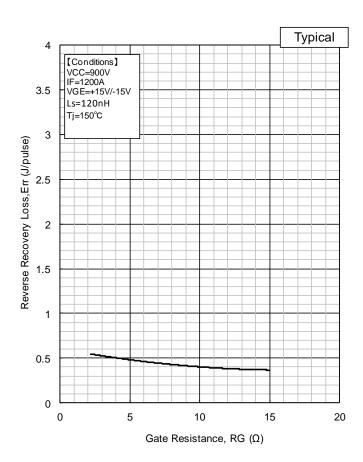
Switching time vs. Forward current of chopper diode





Turn-on loss vs. Gate Resistance

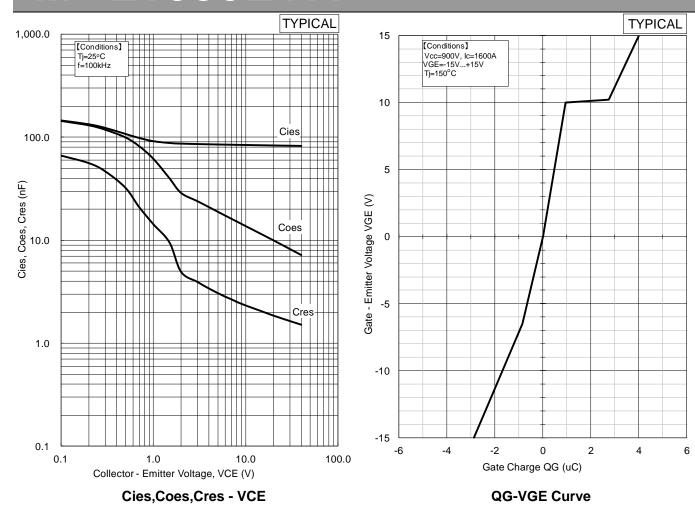
Turn-off loss vs. Gate Resistance

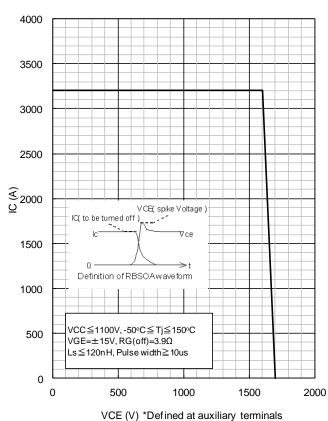


Recovery loss vs. Gate Resistance of chopper diode

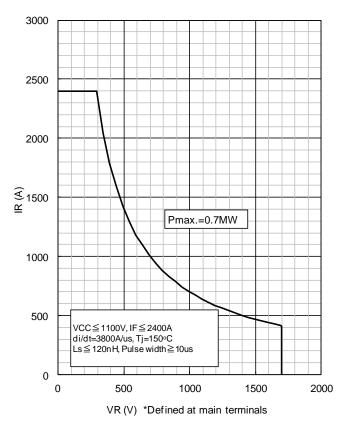
IGBT MODULE Spec.No.IGBT-SP-15017 R4 P7

MBL1600E17F





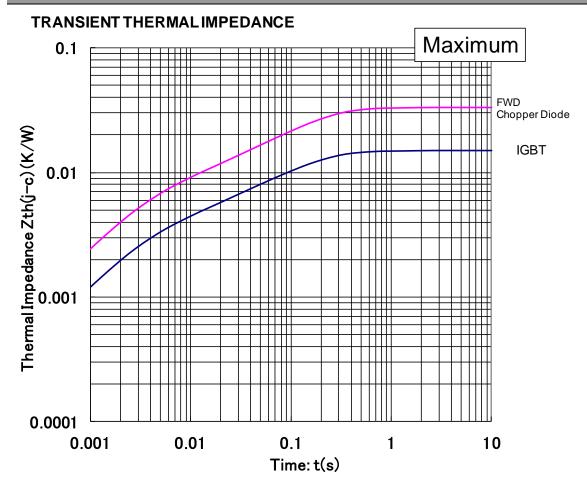
RBSOA



RecSOA of chopper diode

PΩ

MBL1600E17F



Transient Thermal Impedance Curve

Curve Approximation Model

 Σ rth[n]*(1-exp(-t/ τ th[n]))

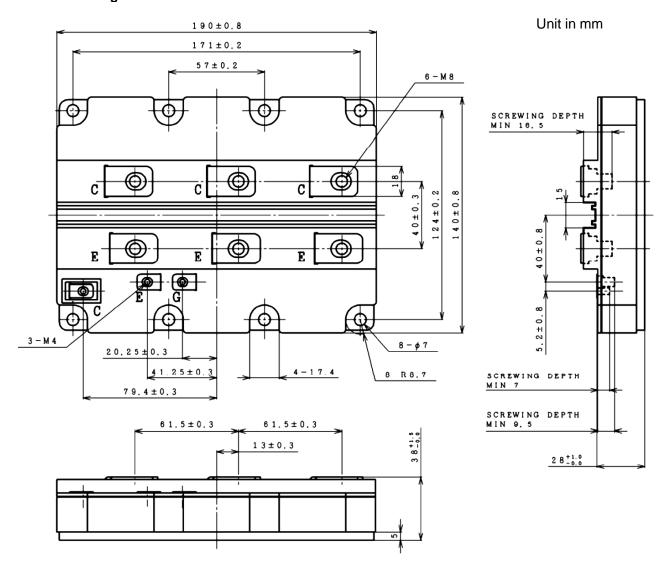
•							
	n	1	2	3	4	Unit	
	т th[n]	1.50E-01	2.58E-02	3.09E-03	5.61E-04	sec	
	rth[n,IGBT]	8.97E-03	2.93E-03	2.70E-03	3.97E-04	K/W	
	rth[n,Diode]	2.15E-02	5.30E-03	5.43E-03	8.00E-04	K/W	

Material declaration

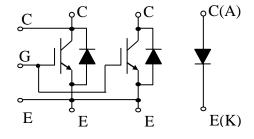
Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

Outline Drawing



Weight: 1300g



Circuit diagram

IGBT MODULE Spec.No.IGBT-SP-15017 R4

MBL1600E17F

Minebea POWER SEMICONDUCTORS

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IGBT MODULE Spec.No.IGBT-SP-15017 R4 P1

MBL1600E17F

Minebea POWER SEMICONDUCTORS

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